


<b>Search Notes</b> 	<b>Application/Control No.</b> 10714434	<b>Applicant(s)/Patent Under Reexamination</b> YOON ET AL.
	<b>Examiner</b> DAQUAN ZHAO	<b>Art Unit</b> 2621

SEARCHED			
Class	Subclass	Date	Examiner
386	95,125-126, 48, 111-112	7/26/2010	DZ

SEARCH NOTES		
Search Notes	Date	Examiner
uspat; uspgpub; usocr; derwent; epo; jpo; ibm_tdb	7/26/2010	dz

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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